imall

Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from, Europe, America and south Asia, supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832 Email & Skype: info@chipsmall.com Web: www.chipsmall.com Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China

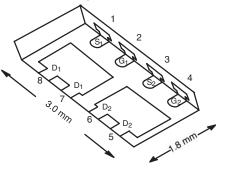




Vishay Siliconix

Dual P-Channel 20-V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	R _{DS(on)} (Ω)	_{S(on)} (Ω) I _D (A)			
- 20	0.058 at V _{GS} = - 4.5 V	- 6 ^a	5.5 nC		
	0.100 at V _{GS} = - 2.5 V	- 6 ^a	5.5 110		



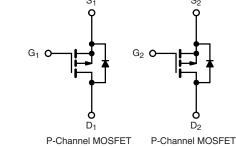
PowerPAK ChipFET Dual



- Halogen-free According to IEC 61249-2-21
 Definition
- TrenchFET[®] Power MOSFET
 - New Thermally Enhanced PowerPAK[®] ChipFET[®] Package
 - Small Footprint Area
 - Small Footprint Area - Low On-Resistance
 - Thin 0.8 mm Profile
 - Thin 0.8 mm Profile

APPLICATIONS

Load Switch, PA Switch, and Charger Switch for Portable
 Devices
 S1
 S2



Ordering Information: Si5947DU-T1-GE3 (Lead (Pb)-free and Halogen-free)

Bottom View

Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V _{DS}	- 20	V	
Gate-Source Voltage		V _{GS}	± 12		
Continuous Drain Current ($T_J = 150 \ ^{\circ}C$)	$T_{C} = 25 °C$ $T_{C} = 70 °C$ $T_{A} = 25 °C$ $T_{A} = 70 °C$	I _D	- 6 ^a - 6 ^a - 5 ^{b, c} - 4 ^{b, c}	A	
Pulsed Drain Current		I _{DM}	- 20	-	
Continuous Source-Drain Diode Current	$T_{C} = 25 \text{ °C}$ $T_{A} = 25 \text{ °C}$	I _S	- 6 ^a - 1.9 ^{b, c}		
Maximum Power Dissipation	$T_{C} = 25 °C$ $T_{C} = 70 °C$ $T_{A} = 25 °C$ $T_{A} = 70 °C$	P _D	10.4 6.7 2.3 ^{b, c} 1.5 ^{b, c}	w	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 150	ე ∘	
Soldering Recommendations (Peak Temperature) ^{d, e}		0	260		

Lot Traceability

and Date Code

Marking Code

DE XXX

Part # Code

THERMAL RESISTANCE RATINGS

Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{b, f}	t ≤ 5 s	R _{thJA}	43	55	°C/W	
Maximum Junction-to-Case (Drain)	Steady State	R _{thJC}	9.5	12	0/11	

Notes:

a. Package limited.

b. Surface Mounted on 1" x 1" FR4 board.

c. t = 5 s.

- d. See Solder Profile (<u>www.vishay.com/ppg?73257</u>). The PowerPAK ChipFET is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.

f. Maximum under Steady State conditions is 105 °C/W.



COMPLIANT

HALOGEN

Si5947DU

Vishay Siliconix



Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, \text{ I}_{D} = -250 \mu\text{A}$	- 20			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I _D = - 250 μA		- 19		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	i _D = - 250 μA		2.6			
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250 \ \mu A$	- 0.6		- 1.5	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 12 V$			± 100	nA	
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = -20 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			- 1		
		$V_{DS} = -20 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 55 ^{\circ}\text{C}$			- 10	μΑ	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \leq$ - 5 V, V_{GS} = - 4.5 V	- 20			Α	
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = - 4.5 V, I _D = - 3.6 A		0.048	0.058	Ω	
		V _{GS} = - 2.5 V, I _D = - 1 A		0.081	0.100		
Forward Transconductance ^a	9 _{fs}	V _{DS} = - 10 V, I _D = - 3.6 A		10		S	
Dynamic ^b				1			
Input Capacitance	C _{iss}			480			
Output Capacitance	C _{oss}	V _{DS} = - 10 V, V _{GS} = 0 V, f = 1 MHz		125		pF	
Reverse Transfer Capacitance	C _{rss}			90			
Total Gate Charge	Qg	$V_{DS} = -10 \text{ V}, V_{GS} = -10 \text{ V}, I_{D} = -5 \text{ A}$		11	17	nC	
				5.5	8.5		
Gate-Source Charge	Q _{gs}	V_{DS} = - 10 V, V_{GS} = - 4.5 V, I_{D} = - 5 A		1.2			
Gate-Drain Charge	Q _{gd}			1.8			
Gate Resistance	Rg	f = 1 MHz		9		Ω	
Turn-On Delay Time	t _{d(on)}			11	20		
Rise Time	t _r	V_{DD} = - 10 V, R_L = 2.5 Ω		42	65	- ns	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong$ - 4 A, V_{GEN} = - 4.5 V, R_g = 1 Ω		33	50		
Fall Time	t _f			50	75		
Turn-On Delay Time	t _{d(on)}			5	10		
Rise Time	t _r	V_{DD} = - 10 V, R_L = 2.5 Ω		15	25		
Turn-Off Delay Time	t _{d(off)}	$I_D\cong$ - 4 A, V_{GEN} = - 10 V, R_g = 1 Ω		25	40		
Fall Time	t _f			10	20		
Drain-Source Body Diode Characterist	cs						
Continuous Source-Drain Diode Current	۱ _S	T _C = 25 °C			- 6	А	
Pulse Diode Forward Current	I _{SM}				- 20	A	
Body Diode Voltage	V _{SD}	I _S = - 4 A, V _{GS} = 0 V		- 0.9	- 1.2	V	
Body Diode Reverse Recovery Time	t _{rr}	I _F = - 4 A, dl/dt = 100 A/μs, T _J = 25 °C		25	50	ns	
Body Diode Reverse Recovery Charge	Q _{rr}			10	20	nC	
Reverse Recovery Fall Time	t _a			9			
Reverse Recovery Rise Time	t _b			16		ns	

Notes:

a. Pulse test; pulse width \leq 300 µs, duty cycle \leq 2 %.

b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

5 20 $V_{GS} = 5 V$ V_{GS} = 3.5 V V_{GS} = 4.5 V $V_{GS} = 3 V$ = 4 V 16 GS 4 I_D - Drain Current (A) I_D - Drain Current (A) 12 3 V_{GS} = 2.5 V 8 2 T_C = 125 °C V_{GS} = 2 V 1 = 25 4 Tc $V_{GS} = 1.5 V$ 0 0 0.0 0.5 1.0 0.0 0.5 1.0 1.5 2.0 2.5 3.0 V_{GS} - Gate-to-Source Voltage (V) V_{DS} - Drain-to-Source Voltage (V) **Output Characteristics Transfer Characteristics** 0.20 800 700 R $_{\text{DS(on)}}$ - On-Resistance (Ω) V_{GS} = 2.5 V 0.16 600 C - Capacitance (pF) C_{iss} 500 0.12 400 300 0.08 200 C_{oss} V_{GS} = 4.5 V 100 C_{rss} 0.04 0 0 4 8 12 16 20 2 4 6 8 10 12 0 I_D - Drain Current (A) V_{DS} - Drain-to-Source Voltage (V) **On-Resistance vs. Drain Current and Gate Voltage** Capacitance 1.6 10 $V_{GS} = 4.5$ V $I_{D} = 5.1 \text{ A}$ I_D = 3.6 A V_{GS} - Gate-to-Source Voltage (V) 8 1.4 R_{DS(on)} - On-Resistance (Normalized) $V_{DS} = 10 V$ 1.2 6 V_{DS} = 16 V 4 1.0 0.8 2 0 0.6 2 8 - 50 - 25 0 25 50 75 0 4 6 10 12 Q_q - Total Gate Charge (nC) T_J - Junction Temperature (°C) **Gate Charge On-Resistance vs. Junction Temperature**

TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

VISHAY

125

150

100

Si5947DU

55 °C

2.0

Τc =

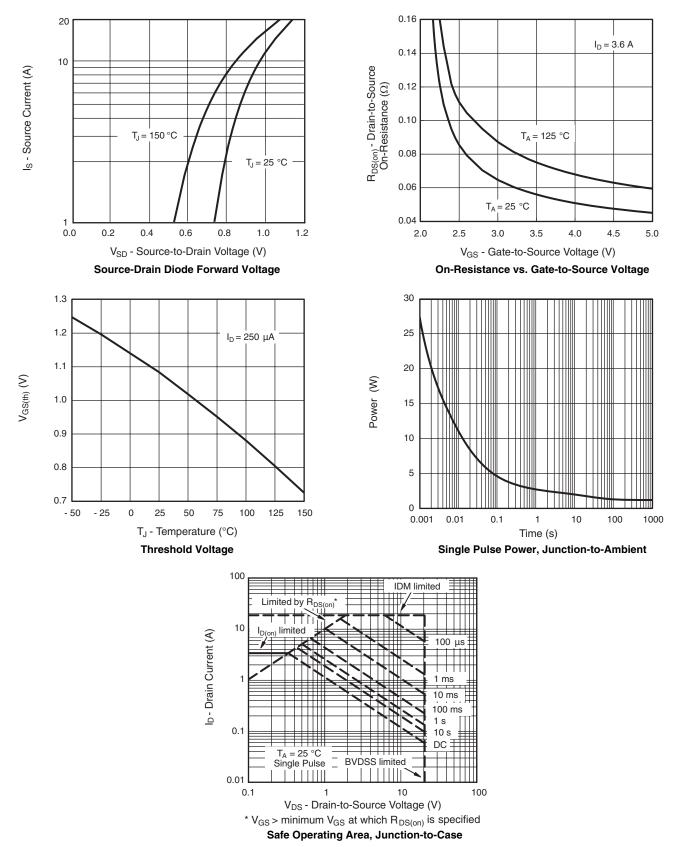
1.5

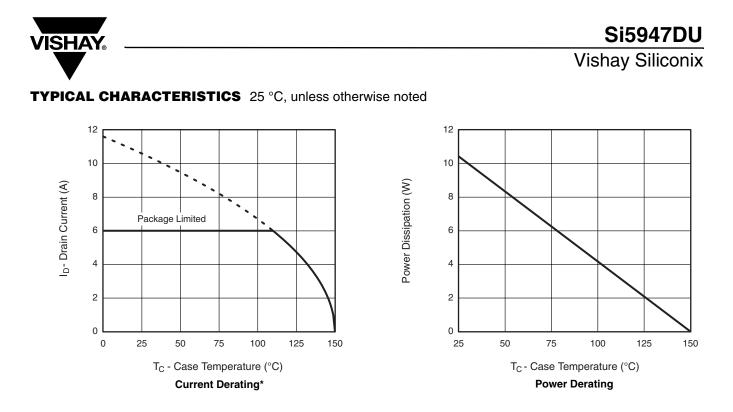
14 16 18 20

Vishay Siliconix

Vishay Siliconix

TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

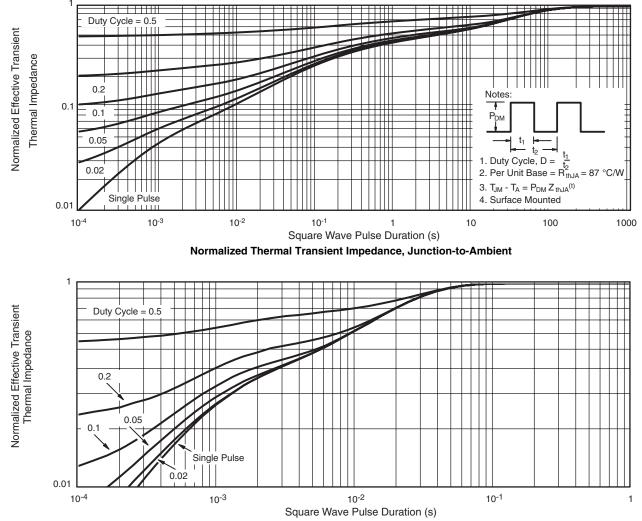




* The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

Vishay Siliconix

TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Case

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?73695.



Vishay

Disclaimer

All product specifications and data are subject to change without notice.

Vishay Intertechnology, Inc., its affiliates, agents, and employees, and all persons acting on its or their behalf (collectively, "Vishay"), disclaim any and all liability for any errors, inaccuracies or incompleteness contained herein or in any other disclosure relating to any product.

Vishay disclaims any and all liability arising out of the use or application of any product described herein or of any information provided herein to the maximum extent permitted by law. The product specifications do not expand or otherwise modify Vishay's terms and conditions of purchase, including but not limited to the warranty expressed therein, which apply to these products.

No license, express or implied, by estoppel or otherwise, to any intellectual property rights is granted by this document or by any conduct of Vishay.

The products shown herein are not designed for use in medical, life-saving, or life-sustaining applications unless otherwise expressly indicated. Customers using or selling Vishay products not expressly indicated for use in such applications do so entirely at their own risk and agree to fully indemnify Vishay for any damages arising or resulting from such use or sale. Please contact authorized Vishay personnel to obtain written terms and conditions regarding products designed for such applications.

Product names and markings noted herein may be trademarks of their respective owners.